

Amendments to the Claims:

No claims have been amended herein. Please note that all claims currently pending and under consideration in the referenced application are shown below. Please enter these claims as amended. This listing of claims will replace all prior versions and listings of claims in the application.

Listing of Claims:

1. (Previously Presented) An assembly method for a plurality of integrated circuit devices and a plurality of mounting substrates comprising:
providing a plurality of integrated circuit devices in multiple lots for assembling in a manufacturing process, each lot of the multiple lots having a plurality of integrated circuit devices therein;
mounting each integrated circuit device of the plurality of integrated circuit devices to a mounting substrate of the plurality of mounting substrates;
placing a substantially unique identification code on each mounting substrate of the plurality of mounting substrates in a readable position thereon;
placing an identification code on each integrated circuit device of the plurality of integrated circuit devices;
correlating the identification code of each integrated circuit device mounted on the mounting substrate with the substantially unique identification code of the mounting substrate;
reading the substantially unique identification code of the mounting substrate of each integrated circuit device of the plurality of integrated circuit devices in each lot of the multiple lots;
performing a series of assembly steps in the manufacturing process on the plurality of integrated circuit devices in the multiple lots, the series of assembly steps including:
generating data related to the series of assembly steps of each integrated circuit device of the plurality of integrated circuit devices through the series of assembly steps;
associating the data generated for each integrated circuit device of the plurality of integrated circuit devices with the substantially unique identification code of an

associated mounting substrate of the plurality of mounting substrates for tracking the multiple lots of the plurality of integrated circuit devices; and at least one assembly step including one of die attach, die cure, wire bond, molding, deflash, lead finish, trim and form, and opens/shorts testing.

2. (Previously Presented) The method of claim 1, wherein each integrated circuit device of the plurality of integrated circuit devices includes a mounting substrate selected from a group comprising a lead frame and a printed circuit board, and wherein each integrated circuit device of the plurality of integrated circuit devices is selected from another group comprising lead frame integrated circuit devices, Chip-on-Board (COB) integrated circuit devices, and flip-chip integrated circuit devices.

3. (Previously Presented) The method of claim 1, wherein placing a substantially unique identification code on each mounting substrate of the plurality of mounting substrates with an optically retrievable substantially unique identification code, and wherein reading the substantially unique identification code of the mounting substrate of each integrated circuit device of the plurality of integrated circuit devices comprises optically retrieving the optically retrievable substantially unique identification code of the mounting substrate of each integrated circuit device of the plurality of integrated circuit devices.

4. (Previously Presented) The method of claim 3, wherein the optically retrievable substantially unique identification code of each mounting substrate comprises one of a bar code, an Optical Character Recognition (OCR) code, and a coded hole matrix and wherein optically retrieving the optically retrievable substantially unique identification code of the mounting substrate of each integrated circuit device of the plurality of integrated circuit devices comprises retrieving the optically retrievable substantially unique identification code of the mounting substrate of each integrated circuit device of the plurality of integrated circuit devices with one of a bar code reader, an OCR reader, and an optical hole reader.

5. (Previously Presented) The method of claim 1, wherein reading the substantially unique identification code of the mounting substrate of each integrated circuit device of the plurality of integrated circuit devices occurs prior to the manufacturing process.

6. (Previously Presented) The method of claim 1, wherein performing a series of assembly steps in the manufacturing process on the plurality of integrated circuit devices comprises advancing the plurality of integrated circuit devices serially through multiple machines associated with the series of assembly steps.

7. (Previously Presented) The method of claim 1, wherein performing a series of assembly steps in the manufacturing process comprises advancing the plurality of integrated circuit devices through parallel machines associated with the series of assembly steps.

8. (Previously Presented) The method of claim 1, wherein generating data related to the series of assembly steps of each integrated circuit device of the plurality of integrated circuit devices through the assembly steps comprises generating at least one of assembly equipment data, assembly personnel data, assembly setup data, and time and date data.

9. (Previously Presented) The method of claim 1, further comprising storing the substantially unique identification code of the mounting substrate of each integrated circuit device of the plurality of integrated circuit devices and wherein associating the data generated for each integrated circuit device of the plurality of integrated circuit devices with the substantially unique identification code of the associated mounting substrate comprises storing the data generated for each integrated circuit device of the plurality of integrated circuit devices in association with the stored substantially unique identification code of the associated mounting substrate.

10. (Previously Presented) The method of claim 9, wherein storing the data generated for each integrated circuit device of the plurality of integrated circuit devices in association with the stored substantially unique identification code of the associated mounting substrate further comprises storing the data in a decentralized manner within a computer system so that at least partial access to the stored data may continue during a failure of a centralized portion of the computer system.

11. (Previously Presented) An assembly method for attaching a plurality of integrated circuit dice to a plurality of first substrates in multiple lots in a manufacturing method comprising:

attaching at least two integrated circuit dice of the plurality of integrated circuit dice on each first substrate of the plurality of first substrates;

separating each integrated circuit die of the at least two integrated circuit dice on each first substrate of the plurality of first substrates, forming one integrated circuit die of a plurality of integrated circuit dice;

providing a plurality of mounting substrates, each mounting substrate of the plurality of mounting substrates marked with a substantially unique identification code;

providing a front-end identification code associated with each integrated circuit die of the plurality of integrated circuit dice;

reading the front-end identification code associated with each integrated circuit die of the plurality of integrated circuit dice;

reading the substantially unique identification code marked on each mounting substrate of the plurality of mounting substrates;

attaching each integrated circuit die of the at least two integrated circuit dice attached to a first substrate to one mounting substrate of the plurality of mounting substrates for forming an integrated circuit device of a plurality of integrated circuit devices;

storing the front-end identification code associated with each integrated circuit die of the plurality of integrated circuit dice in each integrated circuit device of the plurality of

integrated circuit devices in association with the substantially unique identification code of an associated mounting substrate of the plurality of mounting substrates; performing an assembly step on each integrated circuit device of the plurality of integrated circuit devices including:
advancing the plurality of integrated circuit devices through at least one assembly step in a substantially continuous manner;
generating data related to the advancement of the plurality of integrated circuit devices through the at least one assembly step; and
associating the data generated for each integrated circuit device of the plurality of integrated circuit devices with the substantially unique identification code of an associated mounting substrate of the plurality of mounting substrates so the plurality of integrated circuit devices may be tracked through the at least one assembly step; and
back-end testing each integrated circuit device of the plurality of integrated circuit devices.

12. (Previously Presented) The method of claim 11, further comprising:
storing a back-end identification code of each integrated circuit device of the plurality of integrated circuit devices in association with the substantially unique identification code of the associated mounting substrate of the plurality of mounting substrates; and
storing back-end testing-related data for each integrated circuit device of the plurality of integrated circuit devices in association with the back-end identification code of each integrated circuit device of the plurality of integrated circuit devices so the plurality of integrated circuit devices may be tracked through back-end testing.

13. (Original) The method of claim 12, wherein storing the back-end identification code of each integrated circuit device of the plurality of integrated circuit devices comprises storing at least one of a fuse ID code and a lot number.

14. (Original) The method of claim 12, wherein the front-end identification code and back-end identification code associated with each integrated circuit device of the plurality of integrated circuit devices are identical.

15. (Previously Presented) The method of claim 11, wherein providing the plurality of mounting substrates comprises providing substrates selected from a group comprising semiconductor wafers, Silicon-on-Sapphire (SOS) substrates, Silicon-on-Insulator (SOI) substrates, and Silicon-on-Glass (SOG) substrates.

16. (Previously Presented) The method of claim 11, wherein attaching at least two integrated circuit dice on each first substrate of the plurality of first substrates comprises attaching integrated circuit dice selected from a group comprising Dynamic Random Access Memory (DRAM) ICs, Static Random Access Memory (SRAM) ICs, Synchronous DRAM (SDRAM) ICs, processor ICs, Application Specific ICs (ASICs), Read Only Memory (ROM) ICs, and Electrically Erasable Programmable ROM (EEPROM) ICs.

17. (Previously Presented) The method of claim 11, further comprising programming each integrated circuit die of the plurality of integrated circuit dice on each mounting substrate of the plurality of mounting substrates to permanently store a substantially unique fuse ID code, wherein reading the front-end identification code associated with each integrated circuit die of the plurality of integrated circuit dice comprises reading the substantially unique fuse ID code programmed into each integrated circuit die of the plurality of integrated circuit dice.

18. (Previously Presented) The method of claim 17, wherein programming each integrated circuit die of the plurality of integrated circuit dice on each mounting substrate of the plurality of mounting substrates to permanently store the substantially unique fuse ID code comprises programming at least one of fuses and anti-fuses in each integrated circuit die of the plurality of integrated circuit dice on each mounting substrate of the plurality of mounting substrates to permanently store the substantially unique fuse ID code.

19. (Previously Presented) The method of claim 11, wherein providing the plurality of mounting substrates comprises marking each mounting substrate of the plurality of mounting substrates with an optically readable, substantially unique mounting substrate ID code selected from a group comprising a bar code, an Optical Character Recognition (OCR) code, and a coded hole matrix.

20. (Previously Presented) The method of claim 19, wherein each mounting substrate of the plurality of mounting substrates comprises one of a plurality of lead frames, and wherein marking each mounting substrate of the plurality of mounting substrates comprises laser scribing a coded hole matrix in a lead frame rail of each lead frame of the plurality of lead frames.

21. (Previously Presented) The method of claim 11, wherein reading the front-end identification code associated with each integrated circuit die of the plurality of integrated circuit dice comprises reading at least one of a lot number, a wafer number, and a fuse ID code associated with each integrated circuit die of the plurality of integrated circuit dice.

22. (Previously Presented) The method of claim 11, wherein reading the substantially unique identification code of each mounting substrate of the plurality of mounting substrates comprises reading the substantially unique identification code of each mounting substrate with at least one of a bar code reader, an Optical Character Recognition (OCR) reader, and an optical hole reader.

23. (Previously Presented) The method of claim 11, wherein reading the substantially unique identification code of each mounting substrate includes verifying the substantially unique identification code of each mounting substrate using a Cycle Redundancy Check (CRC).

24. (Previously Presented) The method of claim 11, wherein providing the plurality of mounting substrates comprises providing at least one of a plurality of lead frames and a plurality of printed circuit boards.

25. (Previously Presented) The method of claim 11, further comprising verifying that the plurality of integrated circuit devices is supposed to progress through the assembly step before advancing the plurality of integrated circuit devices through the at least one assembly step.

26. (Previously Presented) The method of claim 11, wherein attaching each integrated circuit die of the at least two of the plurality of integrated circuit dice comprises attaching each integrated circuit die of the at least two integrated circuit dice of the plurality of integrated circuit dice using at least one of a Chip-on-Board (COB) technique and a flip-chip technique.